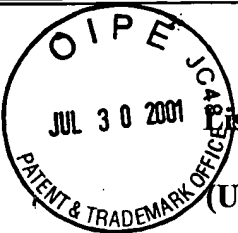
 <p><b>Form PTO-1449 Modified</b></p> <p><b>List of Patents and Publications Cited by Applicant</b> (Use several sheets if necessary)</p> <p><b>U.S. Patent Department of Commerce</b> <b>Patent and Trademark Office</b></p>					<b>Docket No.:</b> 45475-00026		<b>Serial No.:</b> 09/687,048	
					<b>Applicants:</b> Tae Heon LEE et al.			
					<b>Filing Date:</b> October 13, 2000		<b>Group:</b> 2811	
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<b>Examiner Initial</b>	<b>Cite Code</b>	<b>Document No.</b>	<b>Date</b>	<b>Name</b>	<b>Class</b>	<b>Subclass</b>		
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<b>EXAMINER:</b> <i>Rebecca Nyquist</i>				<b>DATE CONSIDERED:</b> <i>2/5/03</i>				

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	<b>Applicants:</b> Tae Heon LEE et al.	
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EXAMINER: <i>Robert Nguyen</i>		DATE CONSIDERED: <i>2/3/03</i>

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		<b>Applicants:</b> Tae Heon LEE et al.			
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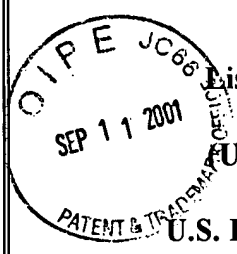
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	C2	

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